Infineon Technologies - C165LM3VHAFXUMA1 Datasheet

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Applications of "Embedded - Microcontrollers"

Details	
Product Status	Obsolete
Core Processor	C166
Core Size	16-Bit
Speed	20MHz
Connectivity	EBI/EMI, SPI, UART/USART
Peripherals	POR, PWM, WDT
Number of I/O	77
Program Memory Size	-
Program Memory Type	ROMless
EEPROM Size	-
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 3.6V
Data Converters	-
Oscillator Type	External
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	100-BQFP
Supplier Device Package	P-MQFP-100
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/c165lm3vhafxuma1

Central Processing Unit (CPU)

The main core of the CPU consists of a 4-stage instruction pipeline, a 16-bit arithmetic and logic unit (ALU) and dedicated SFRs. Additional hardware has been spent for a separate multiply and divide unit, a bit-mask generator and a barrel shifter.

Based on these hardware provisions, most of the C165's instructions can be executed in just one machine cycle which requires 80 ns at 25 MHz CPU clock. For example, shift and rotate instructions are always processed during one machine cycle independent of the number of bits to be shifted. All multiple-cycle instructions have been optimized so that they can be executed very fast as well: branches in 2 cycles, a 16×16 bit multiplication in 5 cycles and a 32-/16 bit division in 10 cycles. Another pipeline optimization, the so-called 'Jump Cache', allows reducing the execution time of repeatedly performed jumps in a loop from 2 cycles to 1 cycle.

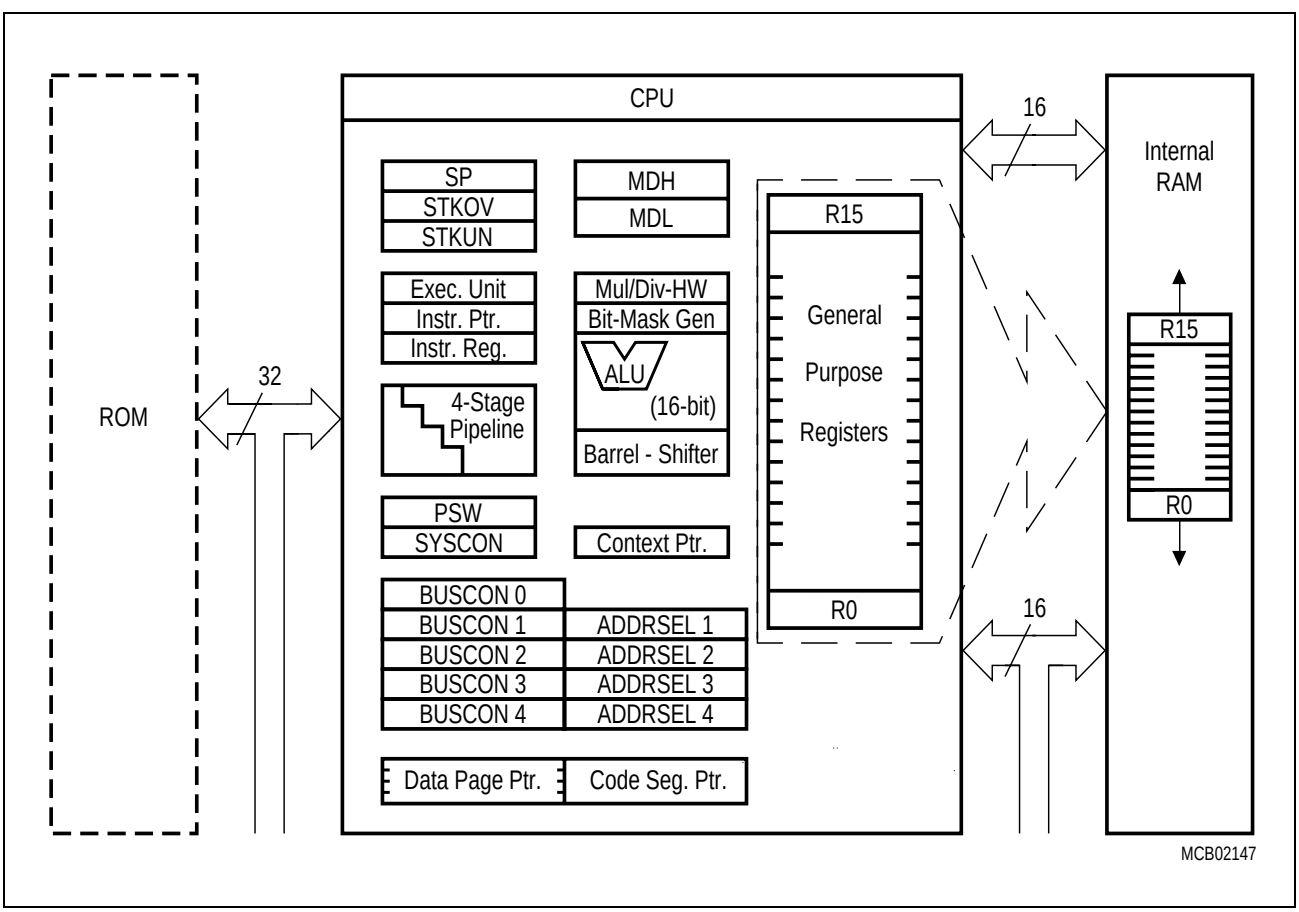


Figure 5 CPU Block Diagram

The CPU has a register context consisting of up to 16 wordwide GPRs at its disposal. These 16 GPRs are physically allocated within the on-chip RAM area. A Context Pointer (CP) register determines the base address of the active register bank to be accessed by the CPU at any time. The number of register banks is only restricted by the available internal RAM space. For easy parameter passing, a register bank may overlap others.

A system stack of up to 1024 words is provided as a storage for temporary data. The system stack is allocated in the on-chip RAM area, and it is accessed by the CPU via the stack pointer (SP) register. Two separate SFRs, STKOV and STKUN, are implicitly compared against the stack pointer value upon each stack access for the detection of a stack overflow or underflow.

The high performance offered by the hardware implementation of the CPU can efficiently be utilized by a programmer via the highly efficient C165 instruction set which includes the following instruction classes:

– Arithmetic Instructions
– Logical Instructions
– Boolean Bit Manipulation Instructions
– Compare and Loop Control Instructions
– Shift and Rotate Instructions
– Prioritize Instruction
– Data Movement Instructions
– System Stack Instructions
– Jump and Call Instructions
– Return Instructions
– System Control Instructions
– Miscellaneous Instructions

The basic instruction length is either 2 or 4 bytes. Possible operand types are bits, bytes and words. A variety of direct, indirect or immediate addressing modes are provided to specify the required operands.

Interrupt System

With an interrupt response time within a range from just 5 to 12 CPU clocks (in case of internal program execution), the C165 is capable of reacting very fast to the occurrence of non-deterministic events.

The architecture of the C165 supports several mechanisms for fast and flexible response to service requests that can be generated from various sources internal or external to the microcontroller. Any of these interrupt requests can be programmed to being serviced by the Interrupt Controller or by the Peripheral Event Controller (PEC).

In contrast to a standard interrupt service where the current program execution is suspended and a branch to the interrupt vector table is performed, just one cycle is ‘stolen’ from the current CPU activity to perform a PEC service. A PEC service implies a single byte or word data transfer between any two memory locations with an additional increment of either the PEC source or the destination pointer. An individual PEC transfer counter is implicity decremented for each PEC service except when performing in the continuous transfer mode. When this counter reaches zero, a standard interrupt is performed to the corresponding source related vector location. PEC services are very well suited, for example, for supporting the transmission or reception of blocks of data. The C165 has 8 PEC channels each of which offers such fast interrupt-driven data transfer capabilities.

A separate control register which contains an interrupt request flag, an interrupt enable flag and an interrupt priority bitfield exists for each of the possible interrupt sources. Via its related register, each source can be programmed to one of sixteen interrupt priority levels. Once having been accepted by the CPU, an interrupt service can only be interrupted by a higher prioritized service request. For the standard interrupt processing, each of the possible interrupt sources has a dedicated vector location.

Fast external interrupt inputs are provided to service external interrupts with high precision requirements. These fast interrupt inputs feature programmable edge detection (rising edge, falling edge or both edges).

Software interrupts are supported by means of the ‘TRAP’ instruction in combination with an individual trap (interrupt) number.

Table 3 shows all of the possible C165 interrupt sources and the corresponding hardware-related interrupt flags, vectors, vector locations and trap (interrupt) numbers.

Note: Interrupt nodes which are not used by associated peripherals, may be used to generate software controlled interrupt requests by setting the respective interrupt request bit (xIR).

The capture trigger (timer T5 to CAPREL) may also be generated upon transitions of GPT1 timer T3's inputs T3IN and/or T3EUD. This is especially advantageous when T3 operates in Incremental Interface Mode.

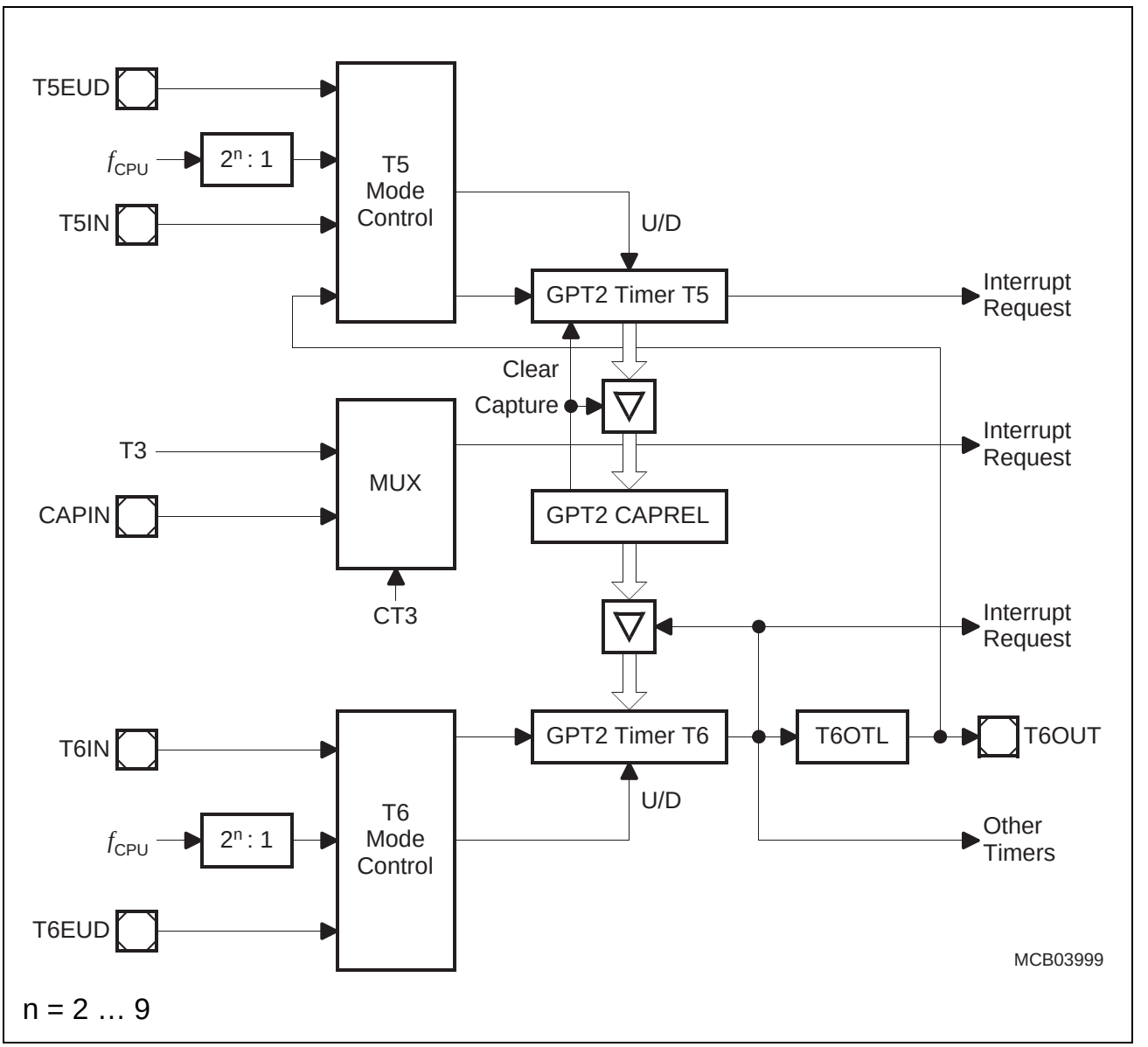


Figure 7 Block Diagram of GPT2

Instruction Set Summary

Table 5 lists the instructions of the C165 in a condensed way.
The various addressing modes that can be used with a specific instruction, the operation of the instructions, parameters for conditional execution of instructions, and the opcodes for each instruction can be found in the **“C166 Family Instruction Set Manual”**.

This document also provides a detailed description of each instruction.

Table 5 Instruction Set Summary

Mnemonic	Description	Bytes
ADD(B)	Add word (byte) operands	2 / 4
ADDC(B)	Add word (byte) operands with Carry	2 / 4
SUB(B)	Subtract word (byte) operands	2 / 4
SUBC(B)	Subtract word (byte) operands with Carry	2 / 4
MUL(U)	(Un)Signed multiply direct GPR by direct GPR (16-16-bit)	2
DIV(U)	(Un)Signed divide register MDL by direct GPR (16-/16-bit)	2
DIVL(U)	(Un)Signed long divide reg. MD by direct GPR (32-/16-bit)	2
CPL(B)	Complement direct word (byte) GPR	2
NEG(B)	Negate direct word (byte) GPR	2
AND(B)	Bitwise AND, (word/byte operands)	2 / 4
OR(B)	Bitwise OR, (word/byte operands)	2 / 4
XOR(B)	Bitwise XOR, (word/byte operands)	2 / 4
BCLR	Clear direct bit	2
BSET	Set direct bit	2
BMOV(N)	Move (negated) direct bit to direct bit	4
BAND, BOR, BXOR	AND/OR/XOR direct bit with direct bit	4
BCMP	Compare direct bit to direct bit	4
BFLDH/L	Bitwise modify masked high/low byte of bit-addressable direct word memory with immediate data	4
CMP(B)	Compare word (byte) operands	2 / 4
CMPD1/2	Compare word data to GPR and decrement GPR by 1/2	2 / 4
CMPI1/2	Compare word data to GPR and increment GPR by 1/2	2 / 4
PRIOR	Determine number of shift cycles to normalize direct word GPR and store result in direct word GPR	2
SHL / SHR	Shift left/right direct word GPR	2
ROL / ROR	Rotate left/right direct word GPR	2
ASHR	Arithmetic (sign bit) shift right direct word GPR	2

Table 6 C165 Registers, Ordered by Name (cont'd)

Name		Physical Address		8-Bit Addr.	Description	Reset Value
CP		$FE10_H$		08_H	CPU Context Pointer Register	$FC00_H$
CRIC	**b**	$FF6A_H$		$B5_H$	GPT2 CAPREL Interrupt Ctrl. Reg.	0000_H
CSP		$FE08_H$		04_H	CPU Code Seg. Pointer Reg. (read only)	0000_H
DP0H	**b**	$F102_H$	**E**	81_H	P0H Direction Control Register	00_H
DP0L	**b**	$F100_H$	**E**	80_H	P0L Direction Control Register	00_H
DP1H	**b**	$F106_H$	**E**	83_H	P1H Direction Control Register	00_H
DP1L	**b**	$F104_H$	**E**	82_H	P1L Direction Control Register	00_H
DP2	**b**	$FFC2_H$		$E1_H$	Port 2 Direction Control Register	0000_H
DP3	**b**	$FFC6_H$		$E3_H$	Port 3 Direction Control Register	0000_H
DP4	**b**	$FFCA_H$		$E5_H$	Port 4 Direction Control Register	00_H
DP6	**b**	$FFCE_H$		$E7_H$	Port 6 Direction Control Register	00_H
DPP0		$FE00_H$		00_H	CPU Data Page Pointer 0 Reg. (10 bits)	0000_H
DPP1		$FE02_H$		01_H	CPU Data Page Pointer 1 Reg. (10 bits)	0001_H
DPP2		$FE04_H$		02_H	CPU Data Page Pointer 2 Reg. (10 bits)	0002_H
DPP3		$FE06_H$		03_H	CPU Data Page Pointer 3 Reg. (10 bits)	0003_H
EXICON	**b**	$F1C0_H$	**E**	$E0_H$	External Interrupt Control Register	0000_H
IDCHIP		$F07C_H$	**E**	$3E_H$	Identifier	$05XX_H$
IDMANUF		$F07E_H$	**E**	$3F_H$	Identifier	1820_H
IDMEM		$F07A_H$	**E**	$3D_H$	Identifier	0000_H
IDMEM2		$F076_H$	**E**	$3B_H$	Identifier	0000_H
IDPROG		$F078_H$	**E**	$3C_H$	Identifier	0000_H
MDC	**b**	$FF0E_H$		87_H	CPU Multiply Divide Control Register	0000_H
MDH		$FE0C_H$		06_H	CPU Multiply Divide Reg. – High Word	0000_H
MDL		$FE0E_H$		07_H	CPU Multiply Divide Reg. – Low Word	0000_H
ODP2	**b**	$F1C2_H$	**E**	$E1_H$	Port 2 Open Drain Control Register	0000_H
ODP3	**b**	$F1C6_H$	**E**	$E3_H$	Port 3 Open Drain Control Register	0000_H
ODP6	**b**	$F1CE_H$	**E**	$E7_H$	Port 6 Open Drain Control Register	00_H
ONES	**b**	$FF1E_H$		$8F_H$	Constant Value 1's Register (read only)	$FFFF_H$
P0H	**b**	$FF02_H$		81_H	Port 0 High Reg. (Upper half of PORT0)	00_H
P0L	**b**	$FF00_H$		80_H	Port 0 Low Reg. (Lower half of PORT0)	00_H

Table 6 C165 Registers, Ordered by Name (cont'd)

Name		Physical Address		8-Bit Addr.	Description	Reset Value
P1H	**b**	$FF06_H$		83_H	Port 1 High Reg. (Upper half of PORT1)	00_H
P1L	**b**	$FF04_H$		82_H	Port 1 Low Reg.(Lower half of PORT1)	00_H
P2	**b**	$FFC0_H$		$E0_H$	Port 2 Register	0000_H
P3	**b**	$FFC4_H$		$E2_H$	Port 3 Register	0000_H
P4	**b**	$FFC8_H$		$E4_H$	Port 4 Register (8 bits)	00_H
P5	**b**	$FFA2_H$		$D1_H$	Port 5 Register (read only)	$XXXX_H$
P6	**b**	$FFCC_H$		$E6_H$	Port 6 Register (8 bits)	00_H
PECC0		$FEC0_H$		60_H	PEC Channel 0 Control Register	0000_H
PECC1		$FEC2_H$		61_H	PEC Channel 1 Control Register	0000_H
PECC2		$FEC4_H$		62_H	PEC Channel 2 Control Register	0000_H
PECC3		$FEC6_H$		63_H	PEC Channel 3 Control Register	0000_H
PECC4		$FEC8_H$		64_H	PEC Channel 4 Control Register	0000_H
PECC5		$FECA_H$		65_H	PEC Channel 5 Control Register	0000_H
PECC6		$FECC_H$		66_H	PEC Channel 6 Control Register	0000_H
PECC7		$FECE_H$		67_H	PEC Channel 7 Control Register	0000_H
PSW	**b**	$FF10_H$		88_H	CPU Program Status Word	0000_H
RP0H	**b**	$F108_H$	**E**	84_H	System Startup Config. Reg. (Rd. only)	XX_H
S0BG		$FEB4_H$		$5A_H$	Serial Channel 0 Baud Rate Generator Reload Register	0000_H
S0CON	**b**	$FFB0_H$		$D8_H$	Serial Channel 0 Control Register	0000_H
S0EIC	**b**	$FF70_H$		$B8_H$	Serial Channel 0 Error Interrupt Ctrl. Reg	0000_H
S0RBUF		$FEB2_H$		59_H	Serial Channel 0 Receive Buffer Reg. (read only)	XX_H
S0RIC	**b**	$FF6E_H$		$B7_H$	Serial Channel 0 Receive Interrupt Control Register	0000_H
S0TBIC	**b**	$F19C_H$	**E**	CE_H	Serial Channel 0 Transmit Buffer Interrupt Control Register	0000_H
S0TBUF		$FEB0_H$		58_H	Serial Channel 0 Transmit Buffer Register (write only)	00_H
S0TIC	**b**	$FF6C_H$		$B6_H$	Serial Channel 0 Transmit Interrupt Control Register	0000_H

Table 6 C165 Registers, Ordered by Name (cont'd)

Name	Physical Address	8-Bit Addr.	Description	Reset Value
SP	$FE12_H$	09_H	CPU System Stack Pointer Register	$FC00_H$
SSCBR	$F0B4_H$ **E**	$5A_H$	SSC Baudrate Register	0000_H
SSCCON b	$FFB2_H$	$D9_H$	SSC Control Register	0000_H
SSCEIC b	$FF76_H$	BB_H	SSC Error Interrupt Control Register	0000_H
SSCRB	$F0B2_H$ **E**	59_H	SSC Receive Buffer	$XXXX_H$
SSCRIC b	$FF74_H$	BA_H	SSC Receive Interrupt Control Register	0000_H
SSCTB	$F0B0_H$ **E**	58_H	SSC Transmit Buffer	0000_H
SSCTIC b	$FF72_H$	$B9_H$	SSC Transmit Interrupt Control Register	0000_H
STKOV	$FE14_H$	$0A_H$	CPU Stack Overflow Pointer Register	$FA00_H$
STKUN	$FE16_H$	$0B_H$	CPU Stack Underflow Pointer Register	$FC00_H$
SYSCON b	$FF12_H$	89_H	CPU System Configuration Register	[1] $0XX0_H$
T2	$FE40_H$	20_H	GPT1 Timer 2 Register	0000_H
T2CON b	$FF40_H$	$A0_H$	GPT1 Timer 2 Control Register	0000_H
T2IC b	$FF60_H$	$B0_H$	GPT1 Timer 2 Interrupt Control Register	0000_H
T3	$FE42_H$	21_H	GPT1 Timer 3 Register	0000_H
T3CON b	$FF42_H$	$A1_H$	GPT1 Timer 3 Control Register	0000_H
T3IC b	$FF62_H$	$B1_H$	GPT1 Timer 3 Interrupt Control Register	0000_H
T4	$FE44_H$	22_H	GPT1 Timer 4 Register	0000_H
T4CON b	$FF44_H$	$A2_H$	GPT1 Timer 4 Control Register	0000_H
T4IC b	$FF64_H$	$B2_H$	GPT1 Timer 4 Interrupt Control Register	0000_H
T5	$FE46_H$	23_H	GPT2 Timer 5 Register	0000_H
T5CON b	$FF46_H$	$A3_H$	GPT2 Timer 5 Control Register	0000_H
T5IC b	$FF66_H$	$B3_H$	GPT2 Timer 5 Interrupt Control Register	0000_H
T6	$FE48_H$	24_H	GPT2 Timer 6 Register	0000_H
T6CON b	$FF48_H$	$A4_H$	GPT2 Timer 6 Control Register	0000_H
T6IC b	$FF68_H$	$B4_H$	GPT2 Timer 6 Interrupt Control Register	0000_H
TFR b	$FFAC_H$	$D6_H$	Trap Flag Register	0000_H
WDT	$FEAE_H$	57_H	Watchdog Timer Register (read only)	0000_H
WDTCON b	$FFAE_H$	$D7_H$	Watchdog Timer Control Register	[2] $00XX_H$
XP0IC b	$F186_H$ **E**	$C3_H$	Software Interrupt Control Register	0000_H

Absolute Maximum Ratings

Table 7 Absolute Maximum Rating Parameters

Parameter	Symbol	Limit Values		Unit	Notes
		min.	max.		
Storage temperature	T_{ST}	- 65	150	°C	–
Junction temperature	T_J	- 40	150	°C	under bias
Voltage on V_{DD} pins with respect to ground (V_{SS})	V_{DD}	- 0.5	6.5	V	–
Voltage on any pin with respect to ground (V_{SS})	V_{IN}	- 0.5	V_{DD} + 0.5	V	–
Input current on any pin during overload condition	–	- 10	10	mA	–
Absolute sum of all input currents during overload condition	–	–	|100|	mA	–
Power dissipation	P_{DISS}	–	1.5	W	–

Note: Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.
During absolute maximum rating overload conditions ($V_{IN} > V_{DD}$ or $V_{IN} < V_{SS}$) the voltage on V_{DD} pins with respect to ground (V_{SS}) must not exceed the values defined by the absolute maximum ratings.

Operating Conditions

The following operating conditions must not be exceeded in order to ensure correct operation of the C165. All parameters specified in the following sections refer to these operating conditions, unless otherwise noticed.

Table 8 Operating Condition Parameters

Parameter	Symbol	Limit Values		Unit	Notes
		min.	max.		
Standard digital supply voltage (5 V versions)	V_{DD}	4.5	5.5	V	Active mode, f_{CPUmax} = 25 MHz
		2.5[1]	5.5	V	PowerDown mode
Reduced digital supply voltage (3 V versions)	V_{DD}	3.0	3.6	V	Active mode, f_{CPUmax} = 20 MHz
		2.5[1]	3.6	V	PowerDown mode
Digital ground voltage	V_{SS}	0		V	Reference voltage
Overload current	I_{OV}	–	± 5	mA	Per pin[2)3)]
Absolute sum of overload currents	$\Sigma\|I_{OV}\|$	–	50	mA	[3)]
External Load Capacitance	C_L	–	100	pF	–
Ambient temperature	T_A	0	70	°C	SAB-C165 …
		- 40	85	°C	SAF-C165 …
		- 40	125	°C	SAK-C165 …

1) Output voltages and output currents will be reduced when V_{DD} leaves the range defined for active mode.

2) Overload conditions occur if the standard operatings conditions are exceeded, i.e. the voltage on any pin exceeds the specified range (i.e. $V_{OV} > V_{DD}$ + 0.5 V or $V_{OV} < V_{SS}$ – 0.5 V). The absolute sum of input overload currents on all pins may not exceed **50 mA**. The supply voltage must remain within the specified limits. Proper operation is not guaranteed if overload conditions occur on functional pins such as XTAL1, $\overline{RD}$, $\overline{WR}$, etc.

3) Not 100% tested, guaranteed by design and characterization.

Parameter Interpretation

The parameters listed in the following partly represent the characteristics of the C165 and partly its demands on the system. To aid in interpreting the parameters right, when evaluating them for a design, they are marked in column “Symbol”:

CC (**C**ontroller **C**haracteristics):
The logic of the C165 will provide signals with the respective timing characteristics.

SR (**S**ystem **R**equirement):
The external system must provide signals with the respective timing characteristics to the C165.

DC Characteristics (Standard Supply Voltage Range)

(Operating Conditions apply)[1)]

Parameter	Symbol	Limit Values		Unit	Test Condition
		min.	max.		
Input low voltage (TTL, all except XTAL1)	V_{IL} SR	– 0.5	0.2 V_{DD} – 0.1	V	–
Input low voltage XTAL1	V_{IL2} SR	– 0.5	0.3 V_{DD}	V	–
Input high voltage (TTL, all except $\overline{\text{RSTIN}}$ and XTAL1)	V_{IH} SR	0.2 V_{DD} + 0.9	V_{DD} + 0.5	V	–
Input high voltage $\overline{\text{RSTIN}}$ (when operated as input)	V_{IH1} SR	0.6 V_{DD}	V_{DD} + 0.5	V	–
Input high voltage XTAL1	V_{IH2} SR	0.7 V_{DD}	V_{DD} + 0.5	V	–
Output low voltage ($\overline{\text{PORT0}}$, $\overline{\text{PORT1}}$, Port 4, ALE, $\overline{\text{RD}}$, $\overline{\text{WR}}$, $\overline{\text{BHE}}$, $\overline{\text{RSTOUT}}$, $\overline{\text{RSTIN}}$[2)])	V_{OL} CC	–	0.45	V	I_{OL} = 2.4 mA
Output low voltage (all other outputs)	V_{OL1} CC	–	0.45	V	I_{OL} = 1.6 mA
Output high voltage[3)] ($\overline{\text{PORT0}}$, $\overline{\text{PORT1}}$, Port 4, ALE, $\overline{\text{RD}}$, $\overline{\text{WR}}$, $\overline{\text{BHE}}$, $\overline{\text{RSTOUT}}$)	V_{OH} CC	2.4	–	V	I_{OH} = - 2.4 mA
		0.9 V_{DD}	–	V	I_{OH} = - 0.5 mA
Output high voltage[3)] (all other outputs)	V_{OH1} CC	2.4	–	V	I_{OH} = - 1.6 mA
		0.9 V_{DD}	–	V	I_{OH} = - 0.5 mA
Input leakage current (Port 5)	I_{OZ1} CC	–	± 200	nA	0 V < V_{IN} < V_{DD}
Input leakage current (all other)	I_{OZ2} CC	–	± 500	nA	0.45 V < V_{IN} < V_{DD}
$\overline{\text{RSTIN}}$ inactive current[4)]	I_{RSTH}[5)]	–	- 10	µA	V_{IN} = V_{IH1}

DC Characteristics (Reduced Supply Voltage Range) (cont'd)
(Operating Conditions apply)[1)]

Parameter	Symbol	Limit Values		Unit	Test Condition
		min.	max.		
PORT0 configuration current[8)]	I_{P0H}[5)]	–	- 5	µA	$V_{IN} = V_{IHmin}$
	I_{P0L}[6)]	- 100	–	µA	$V_{IN} = V_{ILmax}$
XTAL1 input current	I_{IL} CC	–	± 20	µA	0 V < V_{IN} < V_{DD}
Pin capacitance[9)] (digital inputs/outputs)	C_{IO} CC	–	10	pF	f = 1 MHz T_A = 25 °C

1) Keeping signal levels within the levels specified in this table, ensures operation without overload conditions. For signal levels outside these specifications also refer to the specification of the overload current I_{OV}.

2) Valid in bidirectional reset mode only.

3) This specification is not valid for outputs which are switched to open drain mode. In this case the respective output will float and the voltage results from the external circuitry.

4) These parameters describe the $\overline{\text{RSTIN}}$ pullup, which equals a resistance of ca. 50 to 250 kΩ.

5) The maximum current may be drawn while the respective signal line remains inactive.

6) The minimum current must be drawn in order to drive the respective signal line active.

7) This specification is valid during Reset and during Hold-mode or Adapt-mode. During Hold-mode Port 6 pins are only affected, if they are used (configured) for $\overline{\text{CS}}$ output and the open drain function is not enabled. The $\overline{\text{READY}}$-pullup is always active, except for Powerdown mode.

8) This specification is valid during Reset and during Adapt-mode.

9) Not 100% tested, guaranteed by design and characterization.

Power Consumption C165 (Standard Supply Voltage Range)

(Operating Conditions apply)

Parameter	Symbol	Limit Values		Unit	Test Condition
		min.	max.		
Power supply current (active) with all peripherals active	I_{DD5}	–	$15 + 1.8 \times f_{CPU}$	mA	$\overline{RSTIN} = V_{IL}$ f_{CPU} in [MHz][1]
Idle mode supply current with all peripherals active	I_{IDX5}	–	$2 + 0.4 \times f_{CPU}$	mA	$\overline{RSTIN} = V_{IH1}$ f_{CPU} in [MHz][1]
Power-down mode supply current	I_{PDO5}	–	50	µA	$V_{DD} = V_{DDmax}$[2]

1) The supply current is a function of the operating frequency. This dependency is illustrated in **Figure 8**. These parameters are tested at V_{DDmax} and maximum CPU clock with all outputs disconnected and all inputs at V_{IL} or V_{IH}.

2) This parameter is tested including leakage currents. All inputs (including pins configured as inputs) at 0 V to 0.1 V or at V_{DD} – 0.1 V to V_{DD}, all outputs (including pins configured as outputs) disconnected.

Power Consumption C165 (Reduced Supply Voltage Range)

(Operating Conditions apply)

Parameter	Symbol	Limit Values		Unit	Test Condition
		min.	max.		
Power supply current (active) with all peripherals active	I_{DD3}	–	$3 + 1.3 \times f_{CPU}$	mA	$\overline{RSTIN} = V_{IL}$ f_{CPU} in [MHz][1]
Idle mode supply current with all peripherals active	I_{IDX3}	–	$1 + 0.4 \times f_{CPU}$	mA	$\overline{RSTIN} = V_{IH1}$ f_{CPU} in [MHz][1]
Power-down mode supply current	I_{PDO3}	–	30	µA	$V_{DD} = V_{DDmax}$[2]

1) The supply current is a function of the operating frequency. This dependency is illustrated in **Figure 8**. These parameters are tested at V_{DDmax} and maximum CPU clock with all outputs disconnected and all inputs at V_{IL} or V_{IH}.

2) This parameter is tested including leakage currents. All inputs (including pins configured as inputs) at 0 V to 0.1 V or at V_{DD} – 0.1 V to V_{DD}, all outputs (including pins configured as outputs) disconnected.

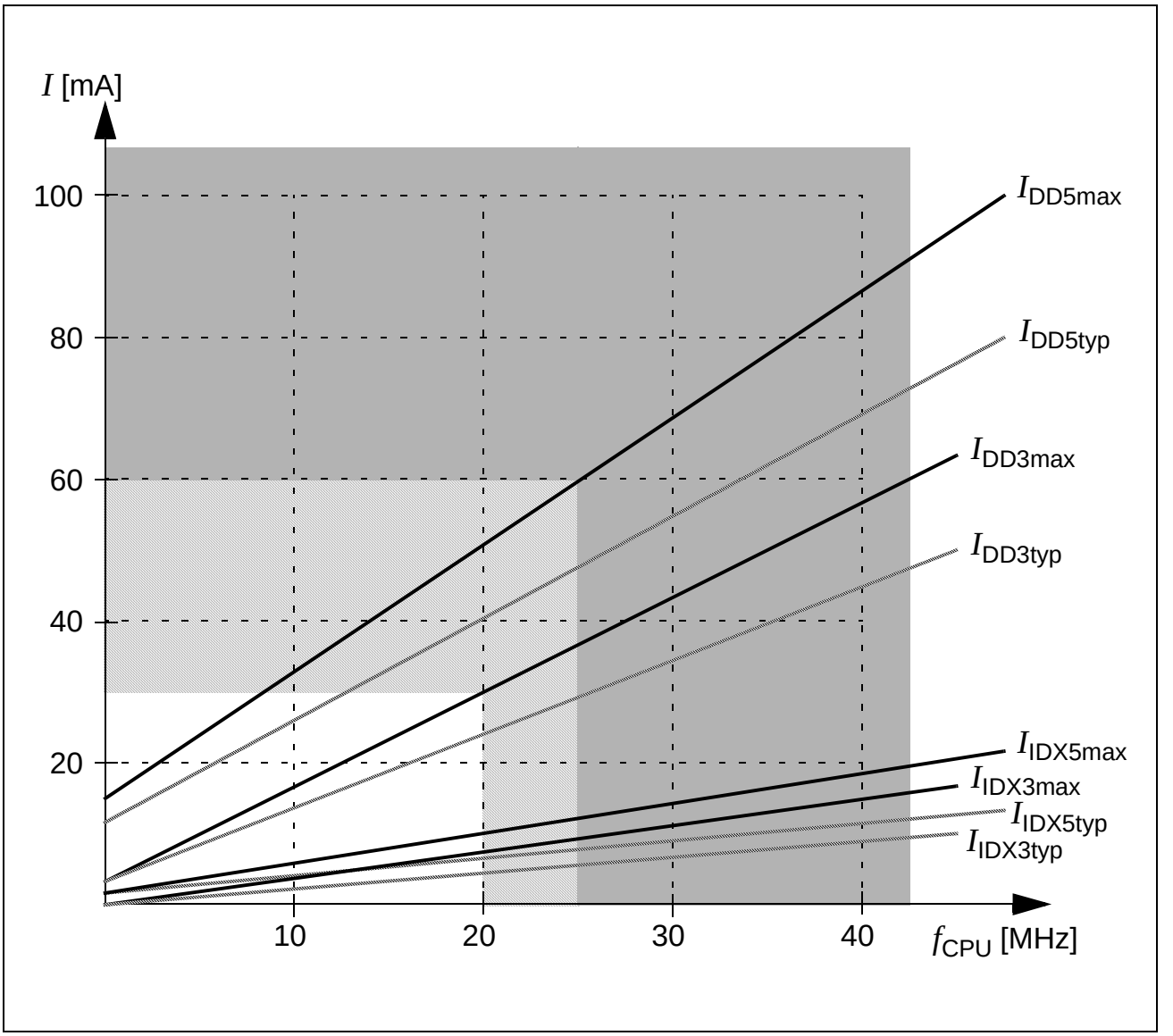
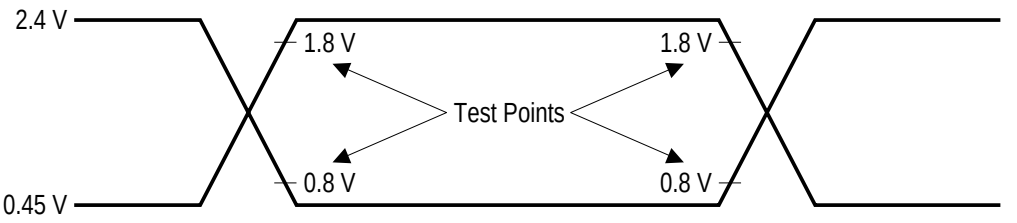


Figure 8 Supply/Idle Current as a Function of Operating Frequency

Testing Waveforms



AC inputs during testing are driven at 2.4 V for a logic ‘1’ and 0.45 V for a logic ‘0’.
Timing measurements are made at V_{IH} min for a logic ‘1’ and V_{IL} max for a logic ‘0’.

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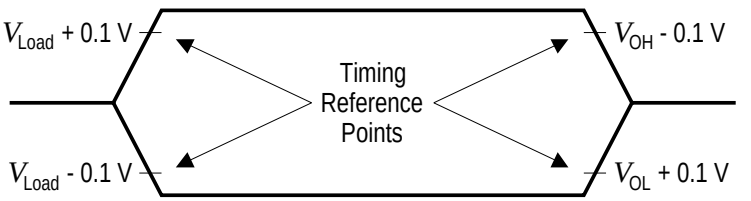
Figure 11 Input Output Waveforms



For timing purposes a port pin is no longer floating when a 100 mV change from load voltage occurs, but begins to float when a 100 mV change from the loaded V_{OH} / V_{OL} level occurs (I_{OH} / I_{OL} = 20 mA).

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Figure 12 Float Waveforms

Multiplexed Bus (Reduced Supply Voltage Range) (cont'd)
(Operating Conditions apply)
ALE cycle time = 6 TCL + $2t_A$ + t_C + t_F (150 ns at 20 MHz CPU clock without waitstates)

Parameter	Symbol		Max. CPU Clock = 20 MHz		Variable CPU Clock 1 / 2TCL = 1 to 20 MHz		Unit
			min.	max.	min.	max.	
Data float after $\overline{RD}$	t_{19}	SR	–	36 + t_F	–	2TCL - 14 + t_F	ns
Data valid to $\overline{WR}$	t_{22}	CC	24 + t_C	–	2TCL - 26 + t_C	–	ns
Data hold after $\overline{WR}$	t_{23}	CC	36 + t_F	–	2TCL - 14 + t_F	–	ns
ALE rising edge after $\overline{RD}$, $\overline{WR}$	t_{25}	CC	36 + t_F	–	2TCL - 14 + t_F	–	ns
Address hold after $\overline{RD}$, $\overline{WR}$	t_{27}	CC	36 + t_F	–	2TCL - 14 + t_F	–	ns
ALE falling edge to $\overline{CS}$[1)]	t_{38}	CC	- 8 - t_A	10 - t_A	- 8 - t_A	10 - t_A	ns
$\overline{CS}$ low to Valid Data In[1)]	t_{39}	SR	–	47+ t_C + $2t_A$	–	3TCL - 28 + t_C + $2t_A$	ns
$\overline{CS}$ hold after $\overline{RD}$, $\overline{WR}$[1)]	t_{40}	CC	57 + t_F	–	3TCL - 18 + t_F	–	ns
ALE fall. edge to $\overline{RdCS}$, $\overline{WrCS}$ (with RW delay)	t_{42}	CC	19 + t_A	–	TCL - 6 + t_A	–	ns
ALE fall. edge to $\overline{RdCS}$, $\overline{WrCS}$ (no RW delay)	t_{43}	CC	- 6 + t_A	–	- 6 + t_A	–	ns
Address float after $\overline{RdCS}$, $\overline{WrCS}$ (with RW delay)	t_{44}	CC	–	0	–	0	ns
Address float after $\overline{RdCS}$, $\overline{WrCS}$ (no RW delay)	t_{45}	CC	–	25	–	TCL	ns
$\overline{RdCS}$ to Valid Data In (with RW delay)	t_{46}	SR	–	20 + t_C	–	2TCL - 30 + t_C	ns
$\overline{RdCS}$ to Valid Data In (no RW delay)	t_{47}	SR	–	45 + t_C	–	3TCL - 30 + t_C	ns
$\overline{RdCS}$, $\overline{WrCS}$ Low Time (with RW delay)	t_{48}	CC	38 + t_C	–	2TCL - 12 + t_C	–	ns
$\overline{RdCS}$, $\overline{WrCS}$ Low Time (no RW delay)	t_{49}	CC	63 + t_C	–	3TCL - 12 + t_C	–	ns

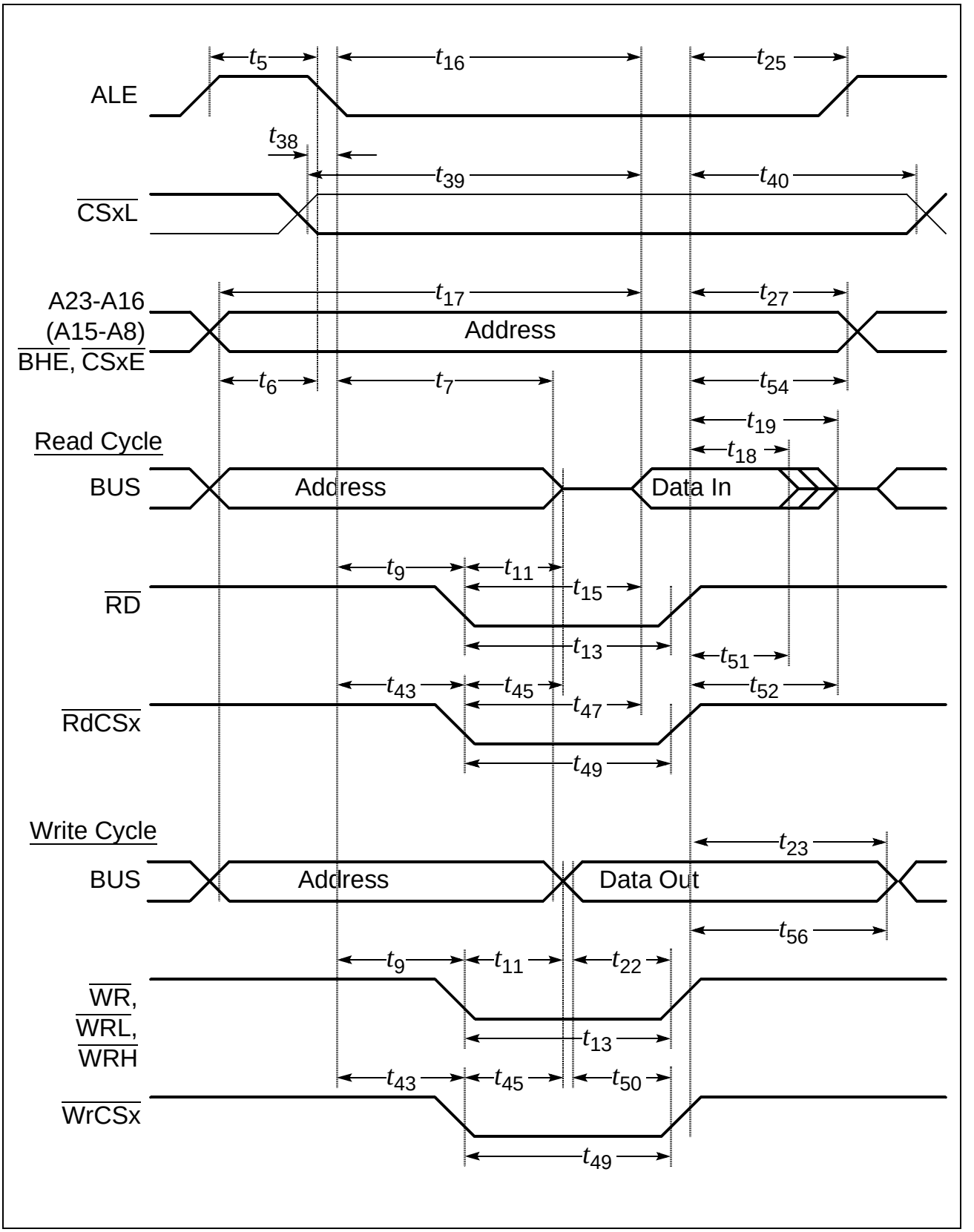


Figure 16 External Memory Cycle: Multiplexed Bus, No Read/Write Delay, Extended ALE

Demultiplexed Bus (Standard Supply Voltage Range) (cont'd)
(Operating Conditions apply)
ALE cycle time = 4 TCL + $2t_A$ + t_C + t_F (80 ns at 25 MHz CPU clock without waitstates)

Parameter	Symbol		Max. CPU Clock = 25 MHz		Variable CPU Clock 1 / 2TCL = 1 to 25 MHz		Unit
			min.	max.	min.	max.	
Data valid to $\overline{WR}$	t_{22}	CC	20 + t_C	–	2TCL - 20 + t_C	–	ns
Data hold after $\overline{WR}$	t_{24}	CC	10 + t_F	–	TCL - 10 + t_F	–	ns
ALE rising edge after $\overline{RD}$, $\overline{WR}$	t_{26}	CC	- 10 + t_F	–	- 10 + t_F	–	ns
Address hold after $\overline{WR}$[2]	t_{28}	CC	0 + t_F	–	0 + t_F	–	ns
ALE falling edge to $\overline{CS}$[3]	t_{38}	CC	- 4 - t_A	10 - t_A	- 4 - t_A	10 - t_A	ns
$\overline{CS}$ low to Valid Data In[3]	t_{39}	SR	–	40 + t_C + $2t_A$	–	3TCL - 20 + t_C + $2t_A$	ns
$\overline{CS}$ hold after $\overline{RD}$, $\overline{WR}$[3]	t_{41}	CC	6 + t_F	–	TCL - 14 + t_F	–	ns
ALE falling edge to $\overline{RdCS}$, $\overline{WrCS}$ (with RW-delay)	t_{42}	CC	16 + t_A	–	TCL - 4 + t_A	–	ns
ALE falling edge to $\overline{RdCS}$, $\overline{WrCS}$ (no RW-delay)	t_{43}	CC	- 4 + t_A	–	- 4 + t_A	–	ns
$\overline{RdCS}$ to Valid Data In (with RW-delay)	t_{46}	SR	–	16 + t_C	–	2TCL - 24 + t_C	ns
$\overline{RdCS}$ to Valid Data In (no RW-delay)	t_{47}	SR	–	36 + t_C	–	3TCL - 24 + t_C	ns
$\overline{RdCS}$, $\overline{WrCS}$ Low Time (with RW-delay)	t_{48}	CC	30 + t_C	–	2TCL - 10 + t_C	–	ns
$\overline{RdCS}$, $\overline{WrCS}$ Low Time (no RW-delay)	t_{49}	CC	50 + t_C	–	3TCL - 10 + t_C	–	ns
Data valid to $\overline{WrCS}$	t_{50}	CC	26 + t_C	–	2TCL - 14 + t_C	–	ns
Data hold after $\overline{RdCS}$	t_{51}	SR	0	–	0	–	ns

Demultiplexed Bus (Standard Supply Voltage Range) (cont'd)
(Operating Conditions apply)
ALE cycle time = 4 TCL + 2t_A + t_C + t_F (80 ns at 25 MHz CPU clock without waitstates)

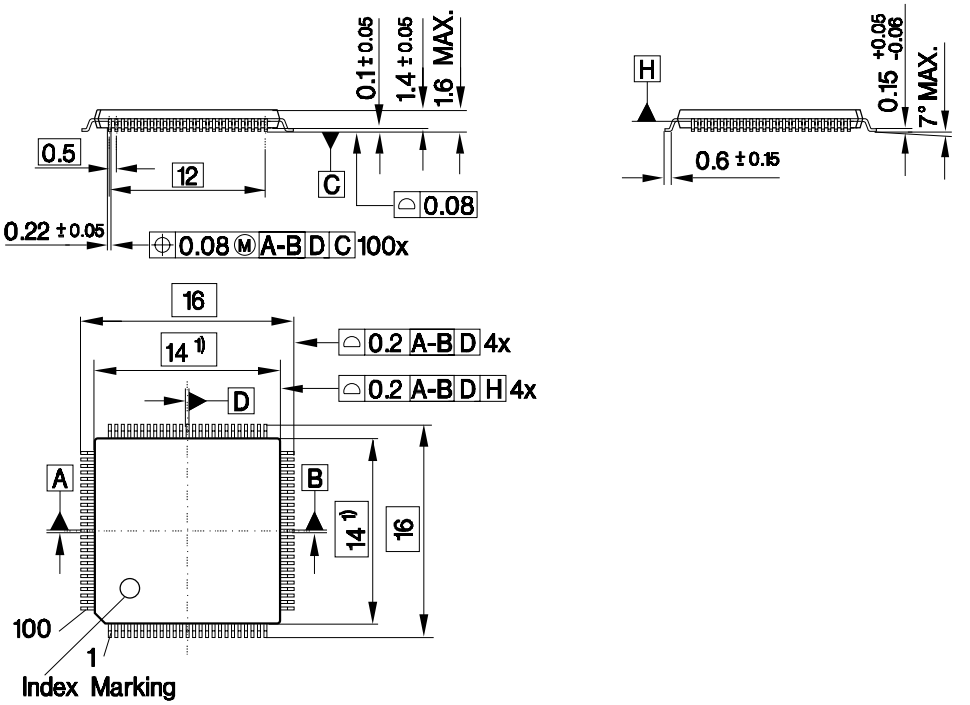
Parameter	Symbol		Max. CPU Clock = 25 MHz		Variable CPU Clock 1 / 2TCL = 1 to 25 MHz		Unit
			min.	max.	min.	max.	
Data float after $\overline{\text{RdCS}}$ (with RW-delay)[1]	t_{53}	SR	–	20 + t_F	–	2TCL - 20 + 2t_A + t_F [1]	ns
Data float after $\overline{\text{RdCS}}$ (no RW-delay)[1]	t_{68}	SR	–	0 + t_F	–	TCL - 20 + 2t_A + t_F [1]	ns
Address hold after $\overline{\text{RdCS}}$, $\overline{\text{WrCS}}$	t_{55}	CC	- 6 + t_F	–	- 6 + t_F	–	ns
Data hold after $\overline{\text{WrCS}}$	t_{57}	CC	6 + t_F	–	TCL - 14 + t_F	–	ns

1) RW-delay and t_A refer to the next following bus cycle (including an access to an on-chip X-Peripheral).

2) Read data are latched with the same clock edge that triggers the address change and the rising $\overline{\text{RD}}$ edge. Therefore address changes before the end of $\overline{\text{RD}}$ have no impact on read cycles.

3) These parameters refer to the latched chip select signals ($\overline{\text{CSxL}}$). The early chip select signals ($\overline{\text{CSxE}}$) are specified together with the address and signal $\overline{\text{BHE}}$ (see figures below).

P-TQFP-100 (SMD)
(Plastic Thin Metric Quad Flat Package)



1) Does not include plastic or metal protrusion of 0.25 max. per side

GPP05614

Sorts of Packing
Package outlines for tubes, trays etc. are contained in our Data Book “Package Information”.

SMD = Surface Mounted Device

Dimensions in mm